Search Notes



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10/773,946 Examiner

JEAN B. FLEURANTIN

Applicant(s)/Patent under Reexamination

LEUNG, YIU-MING

Art Unit

2162

	SEARCHED				
Class	Subclass	Date	Examiner		
707	1-10	12/21/2006	JBF		
707	100-104.1	12/21/2006	JBF		
707	200-206	12/21/2006	JBF		
709	217-218	12/21/2006	JBF		
715	214-215	12/21/2006	JBF		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST (US PG PUB, US PT, EPO, JPO, DERWENT & IBM TDB).	12/21/2006	JBF		
707/CCLS & 709/CCLS & 715/CCLS Inventors Sarch & all related applications have been reviewed for possible Double Patenting.	12/21/2006	JBF		
NPL - ACM	12/21/2006	JBF		
NPL - IEEE	12/21/2006	JBF		
Consulted - TQAS Panel 101	7/6/2006	JBF		